

## VBM2625 Datasheet

P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY		
V <sub>DS</sub>	-60	V
$R_{DS(on)}$ $V_{GS} = 10$ V	19	mΩ
$R_{DS(on)}$ $V_{GS} = 4.5$ V	26	mΩ
I <sub>D</sub>	-50	А
Configuration	Sin	gle

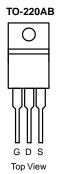
### **FEATURES**

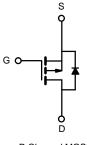
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % UIS Tested

#### **APPLICATIONS**

Load Switch







P-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 60	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 25 °C		- 50	
	T <sub>C</sub> = 70 °C		- 46	
	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-39	
	T <sub>A</sub> = 70 °C		-34	— A
Pulsed Drain Current		I <sub>DM</sub>	- 200	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	- 45	
Single Pulse Avalanche Energy	L = 0.1 MH	E <sub>AS</sub>	101	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	69 <sup>a</sup>	
	T <sub>A</sub> = 25 °C	۱ <sub>S</sub>	20 <sup>b</sup>	— A
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		104.2 <sup>a</sup>	
	T <sub>C</sub> = 70 °C		66.7 <sup>a</sup>	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>b</sup>	W
	T <sub>A</sub> = 70 °C		2 <sup>b</sup>	
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATI	NGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b</sup>	Steady State	R <sub>thJA</sub>	33	40	°C/W
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.98	1.2	C/VV

Notes:

<sup>a. Based on T<sub>C</sub> = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.</sup> 

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C,	unless othe	erwise noted)				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = -250 \mu A$	- 60			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		68		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η 200 μΛ		- 5.2		mv/ C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1		- 3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zerra Octo Maltana Daria Oramant		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	
Zero Gate Voltage Drain Current	IDSS	$V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			- 10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = -5 V, V_{GS} = -10 V$	- 120			Α
Drain-Source On-State Resistance <sup>a</sup>	_	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 30 A		19		
	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 20 A		26		— mΩ
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 50 A	20			S
Dynamic <sup>b</sup>					•	
Input Capacitance	C <sub>iss</sub>			3700		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		390		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			290		
Total Cata Charge		$V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_{D} = -55$ A		76	115	
Total Gate Charge	Qg			38	60	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -30$ V, $V_{GS} = -4.5$ V, $I_{D} = -55$ A		16		nC
Gate-Drain Charge	Q <sub>gd</sub>			19		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		5.2		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 2 V, $R_L$ = 2 $\Omega$		7	15	]
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D}\cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_{g}$ = 1 $\Omega$		70	110	ns
Fall Time	t <sub>f</sub>			40	60	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 69	^
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 150	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 30 A		- 1	- 1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			45	68	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L _ 50 A di/dt _ 100 A/up T _ 25 °C		59	120	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = - 50 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		29		
Reverse Recovery Rise Time	t <sub>b</sub>	1		16		ns

Notes:

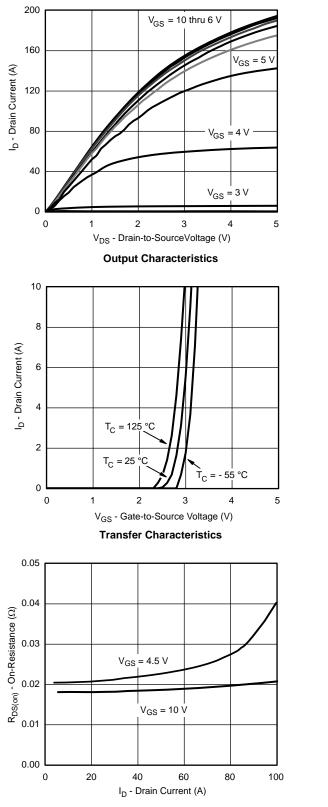
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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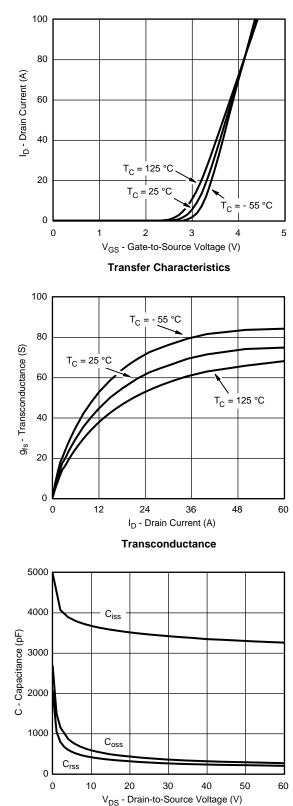
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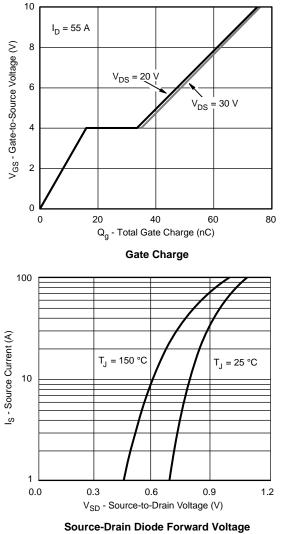
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

**On-Resistance vs. Drain Current** 

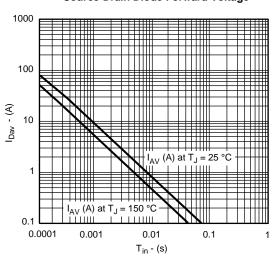


Capacitance

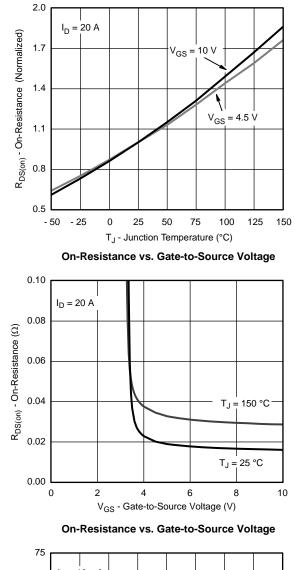


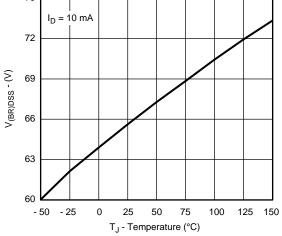


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Single Pulse Avalanche Current Capability vs. Time





Drain-Source Breakdown Voltage vs. Junction Temperature



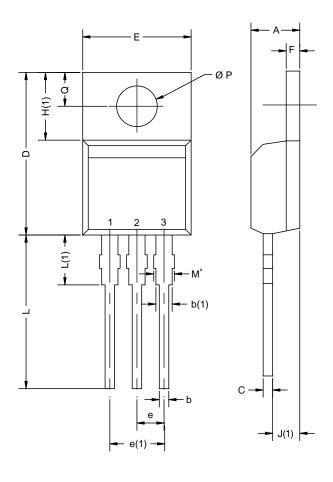
#### 60 0.8 50 0.5 I<sub>D</sub> - Drain Current (A) V<sub>GS(th)</sub> Variance (V) 40 $I_{D} = 250 \ \mu A$ $I_D = 1 \text{ mA}$ 0.2 30 20 - 0.1 10 0 - 0.4 - 50 - 25 0 100 0 25 50 75 100 125 150 25 50 75 125 150 T<sub>J</sub> - Temperature(°C) T<sub>C</sub> - Case Temperature (°C) Threshold Voltage Max. Drain Current vs. Case Temperature 140 1000 Limited by R<sub>DS(on)</sub> 120 10 µs 100 100 I<sub>D</sub> - Drain Current (A) Power (W) 00 µs 80 10 60 1 ms 10 ms 100 ms, DC 40 1 20 BVDSS T<sub>C</sub> = 25 °C Limited Single Pulse 1 | | | | 0 0.1 0 25 50 75 100 125 150 0.1 $\begin{array}{ccc} 1 & 10 \\ V_{DS} \text{ - Drain-to-Source Voltage (V)} \end{array}$ 100 T<sub>J</sub> - Temperature (°C) \* $V_{GS}$ > minimum $V_{GS}$ at which $R_{DS(on)}$ is specified Power Derating, Junction-to-Case Safe Operating Area, Junction-to-Case Duty Cycle = 0.5 Normalized Effective Transient Thermal Impedance 0.2 0.1 0.1 0.05 0.02 Single Pulse 0.01 10<sup>-3</sup> 10-4 10-2 10-1 1

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-220AB**



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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